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Docket No.: S4-03P07726

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By

Date: March 20, 2006

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applic. No.	:	10/566,561	Confirmation No.:	N/A
Applicant	:	Andreas Läufer, et al.		
Filed	:	January 31, 2006		
Title	:	Method for Diagnosing Driver Outputs and Diagnosis Pulse Manager		
Art Unit	:	N/A		
Examiner	:	to be assigned		
Docket No.	:	S4-03P07726		
Customer No.	:	24131		

**INFORMATION DISCLOSURE STATEMENT**

Hon. Commissioner for Patents  
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are cited herewith:

Bonn, et al.: "Localizing Diagnostic Testing of Relay Driver Circuits", IBM Corporation Technical Disclosure Bulletin, XP-002304699, Vol. 27, No. 3, August 1984, pgs. 1784 -1786.

**Alfred K. Dassler**  
**52,794**

Respectfully submitted,

For Applicants

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## FORM PTO-1449 (SUBSTITUTE)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE  
STATEMENT BY APPLICANT  
(37 CFR 1.98(b))Attorney Docket No.:  
S4-03P07726Applic. No.  
10/566,561

## Applicant

Andreas Läufer, et al.

Filing Date  
January 31, 2006Group Art Unit  
N/A

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A						
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						

## FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES   NO
	J						
	K						
	L						
	M						
	N						

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

/DS/	O	Bonn, et al.: " Localizing Diagnostic Testing of Relay Driver Circuits", IBM Corporation Technical Disclosure Bulletin, XP-002304699, Vol. 27, No. 3, August 1984, pgs. 1784 -1786
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EXAMINER	/Daniel St Cyr/	DATE CONSIDERED 08/24/2009

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.